MSKSEMI















ESD

TVS

TSS

MOV

GDT

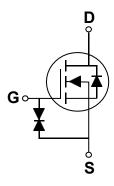
PLED

Broduct data sheet





SOT-23



Features

- 30V,0.5A, RDS(ON) =1.0Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

Applications

- Motor Drive
- Power Tools
- LED Lighting

| BVDSS | RDSON | ID |
|-------|-------|------|
| 30V | 1.0Ω | 0.5A |

Absolute Maximum Ratings Tc=25°C unless otherwise noted

| Symbol | Parameter | Rating | Units |
|------------------|---|------------|-------|
| V _{DS} | Drain-Source Voltage | 30 | V |
| V _G s | Gate-Source Voltage | ±20 | V |
| | Drain Current – Continuous (T _A =25°C) | 0.5 | А |
| ID | Drain Current – Continuous (T _A =70°C) | 0.3 | Α |
| I _{DM} | Drain Current – Pulsed ¹ | 1.0 | Α |
| В | Power Dissipation (T _A =25°C) | 0.35 | W |
| P _D | Power Dissipation – Derate above 25°C | 0.003 | W/°C |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| TJ | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Characteristics

| Symbol | Parameter | Тур. | Max. | Unit |
|--------|--|------|------|------|
| Reja | Thermal Resistance Junction to ambient | | 357 | °C/W |





Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|------------------|--------------------------------|--|------|------|------|------|
| BV_{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V , I _D =250uA | 30 | | | V |
| ı | Drain Source Lookage Current | V _{DS} =30V , V _{GS} =0V , T _J =25°C | | | 1 | uA |
| IDSS | Drain-Source Leakage Current | V _{DS} =25V , V _{GS} =0V , T _J =125°C | | | 100 | uA |
| I _{GSS} | Gate-Source Leakage Current | V _{GS} =±20V , V _{DS} =0V | | | ±10 | uA |

On Characteristics

| | | V _{GS} =10V , I _D =0.2A | | 1.0 | 1.5 | Ω |
|---------------------|--------------------------|--|-----|-----|-----|---|
| R _{DS(ON)} | | V _{GS} =4.5V , I _D =0.1A | | 1.5 | 2.5 | Ω |
| V _{GS(th)} | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =250uA | 0.8 | 1.1 | 1.5 | V |
| gfs | Forward Transconductance | V _{DS} =10V , I _D =0.2A | | 0.5 | | S |

Dynamic and switching Characteristics

| Qg | Total Gate Charge ^{2,3} | | 3.7 | - | |
|---------------------|-------------------------------------|---|----------|---|----|
| Q _{gs} | Gate-Source Charge ^{2, 3} | V_{DS} =30V , V_{GS} =10V , I_{D} =0.2A | 0.9 | | nC |
| Q_{gd} | Gate-Drain Charge ^{2, 3} | | 0.4 | | |
| T _{d(on)} | Turn-On Delay Time ^{2, 3} | | 3 | | |
| Tr | Rise Time ^{2, 3} | V_{DD} =30V , V_{GS} =10V , R_{G} =6 Ω | 5 | | |
| T _{d(off)} | Turn-Off Delay Time ^{2, 3} | I _D =0.2A | 14 | | ns |
| Tf | Fall Time ^{2, 3} | | 9 | | |
| Ciss | Input Capacitance | | 25.5 | | |
| Coss | Output Capacitance | V _{DS} =30V , V _{GS} =0V , F=1MHz | 17 | | pF |
| Crss | Reverse Transfer Capacitance | | 7.8 | | |

Drain-Source Diode Characteristics and Maximum Ratings

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-----------------|---------------------------|---|------|------|------|------|
| ls | Continuous Source Current | V-=V-=OV Force Current | | | 0.5 | Α |
| Ism | Pulsed Source Current | V _G =V _D =0V , Force Current | | | 1.0 | Α |
| V _{SD} | Diode Forward Voltage | V _{GS} =0V , I _S =0.2A , T _J =25°C | | | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _R =30V, I _S =0.2A | | 3.4 | | ns |
| Qrr | Reverse Recovery Charge | dl/dt=100A/µs, Tյ=25°C | | 0.7 | | nC |

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- $\begin{array}{ll} 2. & \text{ The data tested by pulsed , pulse width} \leqq 300 us \text{ , duty cycle} \leqq 2\%. \\ 3. & \text{ Essentially independent of operating temperature.} \end{array}$

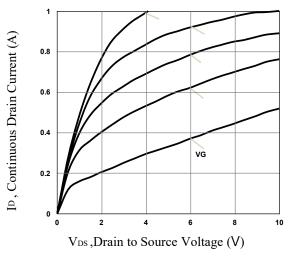


Fig.1 Typical Output Characteristics

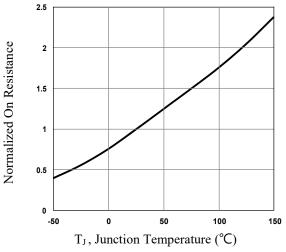


Fig.3 Normalized RDSON vs. TJ

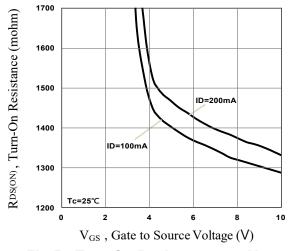


Fig.5 Turn-On Resistance vs. V_{GS}

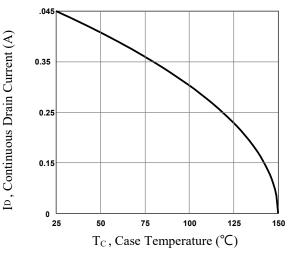


Fig.2 Continuous Drain Current vs. Tc

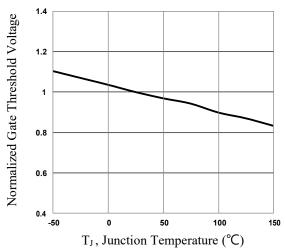


Fig.4 Normalized V_{th} vs. T_J

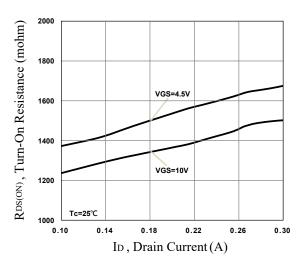


Fig.6 Turn-On Resistance vs. ID



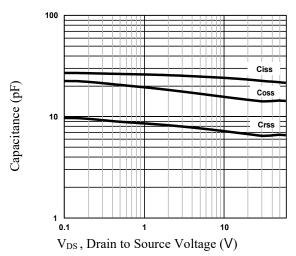


Fig.7 Capacitance Garacteristics

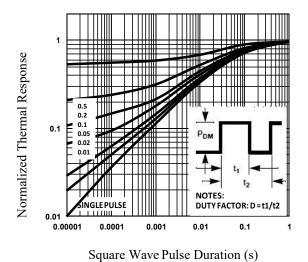


Fig.9 Normalized Transient

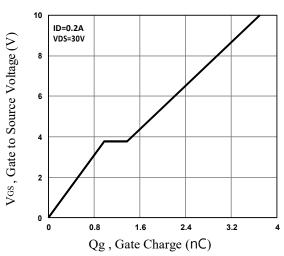
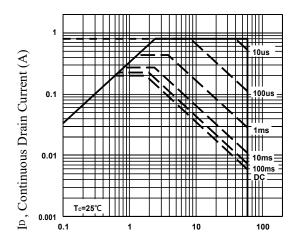


Fig.8 Gate Charge Characteristics

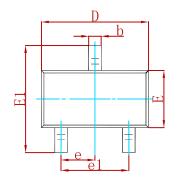


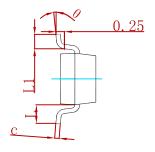
V_{DS}, Drain to Source Voltage(V)

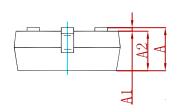
Fig.10 Maximum Safe Operation Area





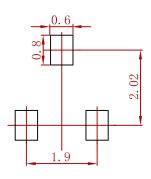






| Symbol | Dimensions | Dimensions In Millimeters | | s In Inches |
|--------|-----------------|---------------------------|-------|-------------|
| Symbol | Min | Max | Min | Max |
| Α | 0.900 | 1.150 | 0.035 | 0.045 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 0.900 | 1.050 | 0.035 | 0.041 |
| b | 0.300 | 0.500 | 0.012 | 0.020 |
| С | 0.080 | 0.150 | 0.003 | 0.006 |
| D | 2.800 | 3.000 | 0.110 | 0.118 |
| Е | 1.200 | 1.400 | 0.047 | 0.055 |
| E1 | 2.250 | 2.550 | 0.089 | 0.100 |
| е | 0.950 | 0.950 TYP | | 7 TYP |
| e1 | 1.800 | 2.000 | 0.071 | 0.079 |
| L | 0.550 REF 0.022 | | REF | |
| L1 | 0.300 | 0.500 | 0.012 | 0.020 |
| θ | 0° | 8° | 0° | 8° |

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

| P/N | PKG | QTY |
|----------------|--------|------|
| NTR4003NT1G-MS | SOT-23 | 3000 |



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